

Search Notes

Application/Control No.

10/511,605

Examiner

Hwei-Siu C. Payer

Applicant(s)/Patent under
Reexamination

YAMAGUCHI ET AL.

Art Unit

3724

SEARCHED

Class	Subclass	Date	Examiner
30	34.1	5-24-07	Payer
	43.4		
	43.5		
	43.6		
	43.7		
	43.8		
	43.9		
	43.91		
	43.92		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner